Notice of References Cited Application/Control No. 10/542,571 Examiner Michael T. Tran Applicant(s)/Patent Under Reexamination UESHIMA ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,760,247 A	07-1988	Keane et al.	235/454
*	В	US-4,861,031 A	08-1989	Simms, Cosmian E.	273/295
*	C	US-5,644,765 A	07-1997	Shimura et al.	707/104.1
*	D	US-6,047,085 A	04-2000	Sato et al.	382/165
*	E	US-2002/0028710 A1	03-2002	Ishihara et al.	463/44
*	F	US-2003/0171142 A1	09-2003	Kaji et al.	463/11
*	G	US-7,006,693 B2	02-2006	Shibuya, Satoru	382/191
*	Ι	US-7,116,824 B2	10-2006	Plaza, Laurent	382/209
	1	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-	•		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001334012 A	12-2001	Japan	ISHIHARA et al.	A63F 01/02
	0	JP 2002102529 A	04-2002	Japan	KAWANO et al.	A63F 11/00
	Р					
	Q					
	R					
	s					
	Т	·				

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.